

# Preliminary datasheet

#### EasyPACK™ module with CoolSiC™ Trench MOSFET and PressFIT / NTC

#### **Features**

- · Electrical features
  - V<sub>DSS</sub> = 1200 V
  - $I_{DN} = 75 A / I_{DRM} = 150 A$
  - Low inductive design
  - Low switching losses
  - High current density
  - Suitable Infineon gate drivers can be found under https://www.infineon.com/gdfinder
- Mechanical features
  - PressFIT contact technology
  - Integrated NTC temperature sensor
  - Rugged mounting due to integrated mounting clamps
  - Package with CTI > 600
  - High current pin

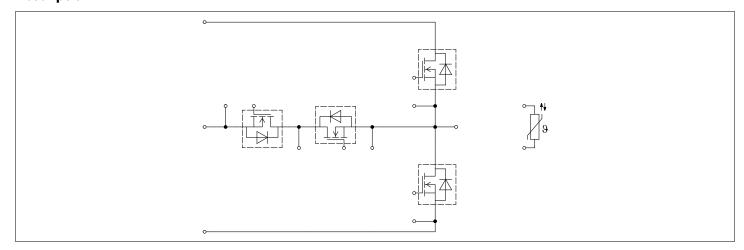
#### **Potential applications**

- High-frequency switching application
- DC/DC converter
- · DC charger for EV

#### **Product validation**

• Qualified for industrial applications according to the relevant tests of IEC 60747, 60749 and 60068

#### **Description**





# **EasyPACK™ module**





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# **EasyPACK™ module**

1 Package



# 1 Package

#### Table 1 Insulation coordination

Parameter	Symbol	Note or test condition	Values	Unit
Isolation test voltage	V <sub>ISOL</sub>	RMS, f = 50 Hz, t = 1 min	3.0	kV
Isolation test voltage NTC	V <sub>ISOL(NTC)</sub>	RMS, f = 50 Hz, t = 1 min	3.0	kV
Internal isolation		basic insulation (class 1, IEC 61140)	Al <sub>2</sub> O <sub>3</sub>	
Comparative tracking index	СТІ		> 600	
Relative thermal index	RTI	frame	130	°C
(electrical)		lid	130	

#### Table 2 Characteristic values

Parameter	Symbol	Note or test condition	Values			
			Min.	Тур.	Max.	
Stray inductance module	$L_{sCE}$			19		nH
Module lead resistance, terminals - chip	R <sub>CC'+EE'</sub>	T <sub>H</sub> = 25 °C, per switch		2.6		mΩ
Storage temperature	$T_{\rm stg}$		-40		130	°C
Mounting force per clamp	F		40		80	N
Weight	G			38		g

**Note**: The current under continuous operation is limited to 50 A rms per connector pin.

# 2 MOSFET, T1 / T2

#### Table 3 Maximum rated values

Parameter	Symbol Note or test condition		Values	Unit	
Drain-source voltage	$V_{DSS}$		T <sub>vj</sub> = 25 °C	1200	V
Implemented drain current	I <sub>DN</sub>			75	А
Continuous DC drain current	I <sub>DDC</sub>	$T_{\rm vj}$ = 175 °C, $V_{\rm GS}$ = 18 V	T <sub>H</sub> = 25 °C	95	А
Repetitive peak drain current	/ <sub>DRM</sub>	verified by design, t <sub>p</sub> lim	verified by design, t <sub>p</sub> limited by T <sub>vjmax</sub>		А
Gate-source voltage, max. transient voltage	V <sub>GS</sub>	D < 0.01		-10/25	V
Gate-source voltage, max. static voltage	$V_{GS}$			-7/20	V

# **EasyPACK™ module**

2 MOSFET, T1 / T2



#### Table 4 Recommended values

Parameter	Symbol	Note or test condition	Values	Unit
On-state gate voltage	V <sub>GS(on)</sub>		1518	V
Off-state gate voltage	V <sub>GS(off)</sub>		-50	V

#### Table 5 Characteristic values

Parameter	Symbol	Note or test condition			Values		Unit
				Min.	Тур.	Max.	
Drain-source on-resistance	R <sub>DS(on)</sub>	I <sub>D</sub> = 75 A	$V_{\rm GS} = 18 \text{ V},$ $T_{\rm vj} = 25 ^{\circ}\text{C}$		8.3		mΩ
			V <sub>GS</sub> = 18 V, T <sub>vj</sub> = 125 °C		13		
			V <sub>GS</sub> = 18 V, T <sub>vj</sub> = 175 °C		16.8		
			V <sub>GS</sub> = 15 V, T <sub>vj</sub> = 25 °C		10		
Gate threshold voltage	V <sub>GS(th)</sub>	$I_D = 33 \text{ mA}, V_{DS} = V_{GS}, T_{vj} = 1 \text{ms pulse at } V_{GS} = +20 \text{ V}.$		3.45	4.3	5.15	V
Total gate charge	Q <sub>G</sub>	$V_{\rm DD}$ = 800 V, $V_{\rm GS}$ = -3/18 V,	T <sub>vj</sub> = 25 °C		0.237		μC
Internal gate resistor	R <sub>Gint</sub>	T <sub>vj</sub> = 25 °C			3.5		Ω
Input capacitance	C <sub>ISS</sub>	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V},$ $V_{GS} = 0 \text{ V}$	T <sub>vj</sub> = 25 °C		7.21		nF
Output capacitance	C <sub>OSS</sub>	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V},$ $V_{GS} = 0 \text{ V}$	T <sub>vj</sub> = 25 °C		0.293		nF
Reverse transfer capacitance	C <sub>rss</sub>	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V},$ $V_{GS} = 0 \text{ V}$	T <sub>vj</sub> = 25 °C		0.02		nF
C <sub>OSS</sub> stored energy	E <sub>OSS</sub>	$V_{\rm DS}$ = 800 V, $V_{\rm GS}$ = -3/18 V,	T <sub>vj</sub> = 25 °C		121		μJ
Drain-source leakage current	I <sub>DSS</sub>	$V_{\rm DS}$ = 1200 V, $V_{\rm GS}$ = -3 V	T <sub>vj</sub> = 25 °C		0.3	296	μA
Gate-source leakage current	I <sub>GSS</sub>	$V_{\rm DS}$ = 0 V, $T_{\rm vj}$ = 25 °C	V <sub>GS</sub> = 20 V			400	nA
Turn-on delay time	t <sub>d on</sub>	$I_{\rm D} = 75  \text{A}, R_{\rm Gon} = 10  \Omega,$	T <sub>vj</sub> = 25 °C		50.4		ns
(inductive load)		$V_{DD} = 800 \text{ V}, V_{GS} = -3/18 \text{ V},$ $t_{dead} = 1000 \text{ ns}, 0.1 \text{ V}_{GS}$	T <sub>vj</sub> = 125 °C		45.7		
		to 0.1 I <sub>D</sub>	T <sub>vj</sub> = 175 °C		43.8		
Rise time (inductive load)	t <sub>r</sub>	$I_{\rm D} = 75  \text{A}, R_{\rm Gon} = 10  \Omega,$	T <sub>vi</sub> = 25 °C		24.5		ns
		$V_{DD} = 800 \text{ V}, V_{GS} = -3/18 \text{ V},$	T <sub>vj</sub> = 125 °C		22.1		
		$t_{\rm dead} = 1000$ ns, 0.1 $t_{\rm D}$ to	T <sub>vi</sub> = 175 °C		21.5		1

(table continues...)

#### **EasyPACK™** module

3 Body diode (MOSFET, T1 / T2)



#### Table 5 (continued) Characteristic values

Parameter	Symbol	Note or test condition			Values		Unit
				Min.	Тур.	Max.	
Turn-off delay time	t <sub>d off</sub>	$I_D = 75 \text{ A}, R_{Goff} = 2.7 \Omega,$ $V_{DD} = 800 \text{ V}, V_{GS} = -3/18 \text{ V},$ $0.9 V_{GS} \text{ to } 0.9 I_D$	T <sub>vj</sub> = 25 °C		63		ns
(inductive load)			T <sub>vj</sub> = 125 °C		71.4		
		0.5 VGS to 0.5 ID	T <sub>vj</sub> = 175 °C		76.4		
Fall time (inductive load)	t <sub>f</sub>	$I_{\rm D} = 75 \text{ A}, R_{\rm Goff} = 2.7 \Omega,$	T <sub>vj</sub> = 25 °C		28.7		ns
		$V_{DD} = 800 \text{ V}, V_{GS} = -3/18 \text{ V},$ 0.9 I <sub>D</sub> to 0.1 I <sub>D</sub>	T <sub>vj</sub> = 125 °C		31		
		0.5 10 to 0.1 10	<i>T</i> <sub>vj</sub> = 175 °C		32.5		
Turn-on energy loss per E <sub>on</sub> pulse	E <sub>on</sub>	$I_{\rm D} = 75 \text{ A}, V_{\rm DD} = 800 \text{ V},$	<i>T</i> <sub>vj</sub> = 25 °C		2.57		mJ
		$L_{\sigma} = 15 \text{ nH}, V_{GS} = -3/18 \text{ V},$ $R_{Gon} = 10 \Omega, \text{ di/dt} =$	T <sub>vj</sub> = 125 °C		2.74		
	$4.11 \text{ kA/}\mu\text{s} (T_{\text{vj}} = 175 \text{ °C}),$ $t_{\text{dead}} = 1000 \text{ ns}$	T <sub>vj</sub> = 175 °C		2.94			
Turn-on energy loss per		/ - 15 pU // - 2/10 //	T <sub>vj</sub> = 25 °C		1.01		mJ
pulse, optimized			T <sub>vj</sub> = 125 °C		1.11		
		10.6 kA/ $\mu$ s (T <sub>vj</sub> = 175 °C), $t_{dead}$ = 100 ns	T <sub>vj</sub> = 175 °C		1.27		
Turn-off energy loss per	E <sub>off</sub>	$I_{\rm D} = 75  \text{A},  V_{\rm DD} = 800  \text{V},$	T <sub>vj</sub> = 25 °C		0.8		mJ
pulse		$L_{\sigma} = 15 \text{ nH}, V_{GS} = -3/18 \text{ V},$ $R_{Goff} = 2.7 \Omega, \text{ dv/dt} = 28.2$	T <sub>vj</sub> = 125 °C		0.86		
		$kV/\mu s (T_{vj} = 175 °C)$	T <sub>vj</sub> = 175 °C		0.91		
Thermal resistance, junction to heat sink	R <sub>thJH</sub>	per MOSFET, $\lambda_{\text{grease}} = 5 \text{ W}$	/(m·K)		0.635		K/W
Temperature under switching conditions	T <sub>vj op</sub>			-40		175	°C
Temperature under overload switching conditions	T <sub>vj over</sub>	Overload, cumulative ma	x. 100 h			200	°C

Note:

The selection of positive and negative gate-source voltages impacts losses and the long-term behavior of the MOSFET and body diode. The design guidelines described in Application Notes AN 2018-09 and AN 2025-02 must be considered to ensure sound operation of the device over the planned lifetime.

# 3 Body diode (MOSFET, T1 / T2)

#### Table 6 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
DC body diode forward current	I <sub>SD</sub>	$T_{\rm vj}$ = 175 °C, $V_{\rm GS}$ = -3 V	T <sub>H</sub> = 25 °C	50	А

## **EasyPACK™ module**

4 MOSFET, T3 / T4



#### Table 7 Characteristic values

Parameter	Symbol	Note or test condition	Note or test condition		Values		Unit
				Min.	Тур.	Max.	
Forward voltage	V <sub>SD</sub>	$V_{SD}$ $I_{SD} = 75 \text{ A}, V_{GS} = -3 \text{ V}$	T <sub>vj</sub> = 25 °C		4.35	5.35	V
			T <sub>vj</sub> = 125 °C		4.05		
			T <sub>vj</sub> = 175 °C		3.9		
current 4.11 kA/	$I_{SD} = 75 \text{ A}, di_s/dt =$	T <sub>vj</sub> = 25 °C		35.2		Α	
		4.11 kA/ $\mu$ s, $V_{DD}$ = 800 V, $V_{GS}$ = -3 V, $t_{dead}$ = 1000 ns	T <sub>vj</sub> = 125 °C		50		
			T <sub>vj</sub> = 175 °C		61.5		
Recovered charge	Qrr	4 1 1 1 1 1 1 1 - 000 1	T <sub>vj</sub> = 25 °C		0.51		μC
			T <sub>vj</sub> = 125 °C		1.12		
			T <sub>vj</sub> = 175 °C		1.59		
Reverse recovery energy	E <sub>rec</sub>	$I_{SD} = 75 \text{ A}, di_s/dt = 4.11$	T <sub>vj</sub> = 25 °C		0.13		mJ
		$kA/\mu s$ ( $T_{vj} = 175 ^{\circ}C$ ), $V_{DD} = 800 ^{\circ}V$ , $V_{GS} = -3 ^{\circ}V$ ,	T <sub>vj</sub> = 125 °C		0.34		
		$t_{\text{dead}} = 1000 \text{ ns}$	T <sub>vj</sub> = 175 °C		0.5		
Reverse recovery energy, optimized	E <sub>rec,o</sub>	$I_{SD} = 75 \text{ A}, di_s/dt = 10.6$	T <sub>vj</sub> = 25 °C		0.89		mJ
		$kA/\mu s$ ( $T_{vj} = 175$ °C),	T <sub>vj</sub> = 125 °C		1.73		1
	$\nu_{DD}$ – 800 v, $\nu_{GS}$ – -3 v,	T <sub>vj</sub> = 175 °C		2.6		1	

# 4 MOSFET, T3 / T4

#### Table 8 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
Drain-source voltage	$V_{DSS}$		T <sub>vj</sub> = 25 °C	1200	V
Implemented drain current	I <sub>DN</sub>			75	А
Continuous DC drain current	I <sub>DDC</sub>	$T_{\rm vj}$ = 175 °C, $V_{\rm GS}$ = 18 V	T <sub>H</sub> = 25 °C	85	А
Repetitive peak drain current	I <sub>DRM</sub>	verified by design, t <sub>p</sub> lim	nited by T <sub>vjmax</sub>	150	А
Gate-source voltage, max. transient voltage	V <sub>GS</sub>	D < 0.01		-10/25	V
Gate-source voltage, max. static voltage	$V_{GS}$			-7/20	V

#### Table 9 Recommended values

Parameter	Symbol	Note or test condition	Values	Unit
On-state gate voltage	V <sub>GS(on)</sub>		1518	V
Off-state gate voltage	V <sub>GS(off)</sub>		-50	V

# EasyPACK™ module

4 MOSFET, T3 / T4



Table 10 Characteristic values

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Тур.	Max.	
Drain-source on-resistance	R <sub>DS(on)</sub>	I <sub>D</sub> = 75 A	$V_{\rm GS} = 18 \text{ V},$ $T_{\rm vj} = 25 ^{\circ}\text{C}$		8.3		mΩ
			$V_{\rm GS} = 18 \text{ V},$ $T_{\rm vj} = 125 ^{\circ}\text{C}$		13		
			$V_{\rm GS} = 18 \text{ V},$ $T_{\rm vj} = 175 ^{\circ}\text{C}$		16.8		
			$V_{\rm GS} = 15 \text{ V},$ $T_{\rm vj} = 25 ^{\circ}\text{C}$		10		
Gate threshold voltage	V <sub>GS(th)</sub>	$I_D = 33 \text{ mA}, V_{DS} = V_{GS}, T_{vj} = 1 \text{ms pulse at } V_{GS} = +20 \text{ V})$		3.45	4.3	5.15	V
Total gate charge	Q <sub>G</sub>	$V_{\rm DD}$ = 800 V, $V_{\rm GS}$ = -3/18 V,	T <sub>vj</sub> = 25 °C		0.237		μC
Internal gate resistor	$R_{Gint}$	T <sub>vj</sub> = 25 °C			3.5		Ω
Input capacitance	C <sub>ISS</sub>	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V},$ $V_{GS} = 0 \text{ V}$	T <sub>vj</sub> = 25 °C		7.21		nF
Output capacitance	C <sub>OSS</sub>	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V},$ $V_{GS} = 0 \text{ V}$	T <sub>vj</sub> = 25 °C		0.293		nF
Reverse transfer capacitance	C <sub>rss</sub>	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V},$ $V_{GS} = 0 \text{ V}$	T <sub>vj</sub> = 25 °C		0.02		nF
C <sub>OSS</sub> stored energy	E <sub>OSS</sub>	$V_{\rm DS}$ = 800 V, $V_{\rm GS}$ = -3/18 V,	T <sub>vj</sub> = 25 °C		121		μJ
Drain-source leakage current	I <sub>DSS</sub>	$V_{\rm DS}$ = 1200 V, $V_{\rm GS}$ = -3 V	T <sub>vj</sub> = 25 °C		0.3	296	μA
Gate-source leakage current	I <sub>GSS</sub>	$V_{\rm DS}$ = 0 V, $T_{\rm vj}$ = 25 °C	V <sub>GS</sub> = 20 V			400	nA
Turn-on delay time	t <sub>d on</sub>	$I_{\rm D} = 75  \text{A}, R_{\rm Gon} = 5.6  \Omega,$	T <sub>vj</sub> = 25 °C		46		ns
(inductive load)		$V_{DD} = 800 \text{ V}, V_{GS} = -3/18 \text{ V},$ $t_{dead} = 1000 \text{ ns}, 0.1 \text{ V}_{GS}$	T <sub>vj</sub> = 125 °C		42.9		
		to 0.1 I <sub>D</sub>	T <sub>vj</sub> = 175 °C		41.1		
Rise time (inductive load)	t <sub>r</sub>	$I_{\rm D} = 75  \text{A}, R_{\rm Gon} = 5.6  \Omega,$	T <sub>vj</sub> = 25 °C		19.9		ns
		$V_{\rm DD}$ = 800 V, $V_{\rm GS}$ = -3/18 V, $t_{\rm dead}$ = 1000 ns, 0.1 I <sub>D</sub> to	T <sub>vj</sub> = 125 °C		17.8		
		0.9 I <sub>D</sub>	T <sub>vj</sub> = 175 °C		17.1		
Turn-off delay time	t <sub>d off</sub>	$I_{\rm D} = 75 \text{ A}, R_{\rm Goff} = 2.7 \Omega,$	T <sub>vj</sub> = 25 °C		64.1		ns
(inductive load)		$V_{DD} = 800 \text{ V}, V_{GS} = -3/18 \text{ V},$ 0.9 $V_{GS}$ to 0.9 $I_{D}$	T <sub>vj</sub> = 125 °C		73.5		
		0.0 163 10 0.0 10	T <sub>vj</sub> = 175 °C		79.2		
Fall time (inductive load)	$t_{f}$	$I_{\rm D} = 75  \text{A}, R_{\rm Goff} = 2.7  \Omega,$	T <sub>vj</sub> = 25 °C		30.7		ns
		$V_{DD} = 800 \text{ V}, V_{GS} = -3/18 \text{ V}, T_{DS} = -3/18 \text{ V}, $	T <sub>vj</sub> = 125 °C		31.9		
		טיייט	T <sub>vj</sub> = 175 °C		32.3		

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(table continues...)

#### **EasyPACK™** module

5 Body diode (MOSFET, T3 / T4)



Table 10 (continued) Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit	
				Min.	Тур.	Max.	
Turn-on energy loss per	E <sub>on</sub>	$I_D = 75 \text{ A}, V_{DD} = 800 \text{ V},$ $L_{\sigma} = 15 \text{ nH}, V_{GS} = -3/18 \text{ V},$ $R_{Gon} = 5.6 \Omega, \text{ di/dt} =$	T <sub>vj</sub> = 25 °C		2.02		mJ
pulse			T <sub>vj</sub> = 125 °C		2.19		
		4.95 kA/ $\mu$ s ( $T_{vj}$ = 175 °C), $t_{dead}$ = 1000 ns	T <sub>vj</sub> = 175 °C		2.43		
Turn-on energy loss per pulse, optimized	E <sub>on,o</sub>	$L_{\sigma} = 15 \text{ nH}, V_{GS} = -3/18 \text{ V},$ $R_{Gon,o} = 0.0 \Omega, \text{ di/dt} =$	T <sub>vj</sub> = 25 °C		0.81		mJ
			T <sub>vj</sub> = 125 °C		0.85		
			T <sub>vj</sub> = 175 °C		0.99		
Turn-off energy loss per	$L_{\sigma}$	$L_{\sigma} = 15 \text{ nH}, V_{GS} = -3/18 \text{ V},$ $R_{Goff} = 2.7 \Omega, \text{ dv/dt} = 25.8$	T <sub>vj</sub> = 25 °C		0.83		mJ
pulse			T <sub>vj</sub> = 125 °C		0.92		
			T <sub>vj</sub> = 175 °C		0.98		
Thermal resistance, junction to heat sink	R <sub>thJH</sub>	per MOSFET, $\lambda_{\text{grease}} = 5 \text{ W/(m·K)}$			0.79		K/W
Temperature under switching conditions	T <sub>vj op</sub>			-40		175	°C
Temperature under overload switching conditions	T <sub>vj over</sub>	Overload, cumulative max. 100 h				200	°C

Note:

The selection of positive and negative gate-source voltages impacts losses and the long-term behavior of the MOSFET and body diode. The design guidelines described in Application Notes AN 2018-09 and AN 2025-02 must be considered to ensure sound operation of the device over the planned lifetime.

# 5 Body diode (MOSFET, T3 / T4)

Table 11 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
DC body diode forward	I <sub>SD</sub>	$T_{\rm vj}$ = 175 °C, $V_{\rm GS}$ = -3 V	T <sub>H</sub> = 25 °C	40	Α
current					

#### Table 12 Characteristic values

Parameter	Symbol	Note or test condition	n	Values			Unit
				Min.	Тур.	Max.	
Forward voltage	$V_{SD}$	$I_{SD} = 75 \text{ A}, V_{GS} = -3 \text{ V}$	T <sub>vj</sub> = 25 °C		4.35	5.35	V
			T <sub>vj</sub> = 125 °C		4.05		
			T <sub>vj</sub> = 175 °C		3.9		1

#### (table continues...)

# **EasyPACK™ module**

6 NTC-Thermistor



# Table 12 (continued) Characteristic values

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Тур.	Max.	
Peak reverse recovery	I <sub>rrm</sub>	$I_{SD}$ = 75 A, di <sub>s</sub> /dt = 4.95 kA/µs, $V_{DD}$ = 800 V, $V_{GS}$ = -3 V, $t_{dead}$ = 1000 ns	T <sub>vj</sub> = 25 °C		40.7		Α
current			T <sub>vj</sub> = 125 °C		58.1		
		VGS - 3 V, tdead - 1000 113	T <sub>vj</sub> = 175 °C		70.5		
Recovered charge	Q <sub>rr</sub>	4 OF 1/4/10 1/ - 000 1/	T <sub>vj</sub> = 25 °C		0.55		μC
			T <sub>vj</sub> = 125 °C		1.18		
			T <sub>vj</sub> = 175 °C		1.61		
Reverse recovery energy	E <sub>rec</sub>	$I_{SD} = 75 \text{ A}, \text{ di}_{s}/\text{dt} = 4.95$ $kA/\mu s (T_{vj} = 175 ^{\circ}\text{C}),$ $V_{DD} = 800 \text{V}, V_{GS} = -3 \text{V},$ $t_{dead} = 1000 \text{ns}$	T <sub>vj</sub> = 25 °C		0.14		mJ
			T <sub>vj</sub> = 125 °C		0.37		
			T <sub>vj</sub> = 175 °C		0.49		
Reverse recovery energy, optimized	kA	$I_{SD} = 75 \text{ A}, \text{ di}_{s}/\text{dt} = 11.1$ kA/µs ( $T_{vj} = 175 ^{\circ}\text{C}$ ),	T <sub>vj</sub> = 25 °C		0.88		mJ
			T <sub>vj</sub> = 125 °C		1.47		
		$V_{\rm DD} = 800 \text{ V}, V_{\rm GS} = -3 \text{ V},$ $t_{\rm dead} = 100 \text{ ns}$	T <sub>vj</sub> = 175 °C		1.92		

# **6** NTC-Thermistor

#### Table 13 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Тур.	Max.	
Rated resistance	R <sub>25</sub>	T <sub>NTC</sub> = 25 °C		5		kΩ
Deviation of R <sub>100</sub>	$\Delta R/R$	$T_{\rm NTC}$ = 100 °C, $R_{100}$ = 493 $\Omega$	-5		5	%
Power dissipation	P <sub>25</sub>	T <sub>NTC</sub> = 25 °C			20	mW
B-value	B <sub>25/50</sub>	$R_2 = R_{25} \exp[B_{25/50}(1/T_2-1/(298,15 \text{ K}))]$		3375		К
B-value	B <sub>25/80</sub>	$R_2 = R_{25} \exp[B_{25/80}(1/T_2-1/(298,15 \text{ K}))]$ 341:		3411		К
B-value	B <sub>25/100</sub>	$R_2 = R_{25} \exp[B_{25/100}(1/T_2-1/(298,15 \text{ K}))]$		3433		К

**Note**: For an analytical description of the NTC characteristics please refer to AN2009-10, chapter 4

#### EasyPACK™ module

7 Characteristics diagrams

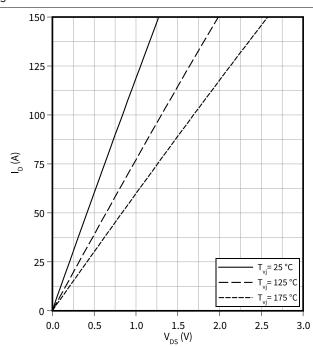


# 7 Characteristics diagrams

#### Output characteristic (typical), MOSFET, T1 / T2

 $I_D = f(V_{DS})$ 

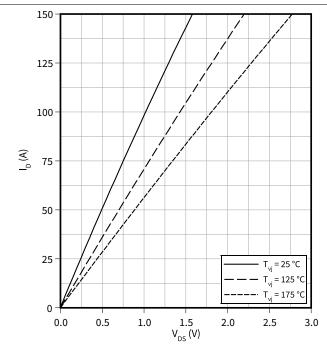
 $V_{GS} = 18 V$ 



#### Output characteristic (typical), MOSFET, T1 / T2

 $I_D = f(V_{DS})$ 

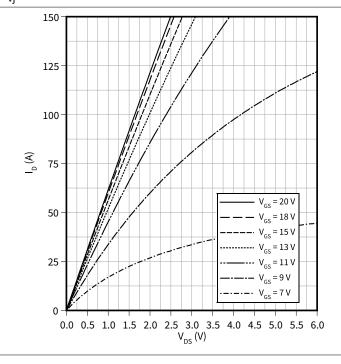
 $V_{GS} = 15 V$ 



#### Output characteristic field (typical), MOSFET, T1 / T2

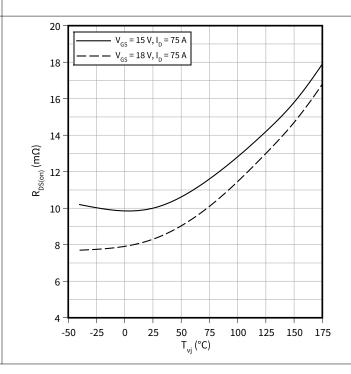
 $I_D = f(V_{DS})$ 

T<sub>vj</sub> = 175 °C



# Drain source on-resistance (typical), MOSFET, T1 / T2 $\,$

 $\mathsf{R}_{\mathsf{DS}(\mathsf{on})} = \mathsf{f}(\mathsf{T}_{\mathsf{v}\mathsf{j}})$ 



#### EasyPACK™ module

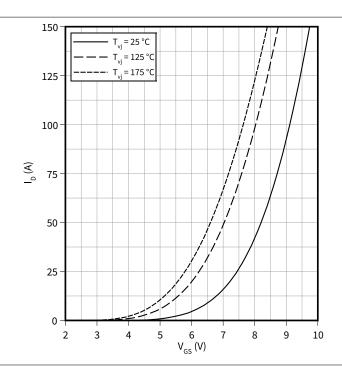
7 Characteristics diagrams



# Transfer characteristic (typical), MOSFET, T1 / T2

$$I_D = f(V_{GS})$$

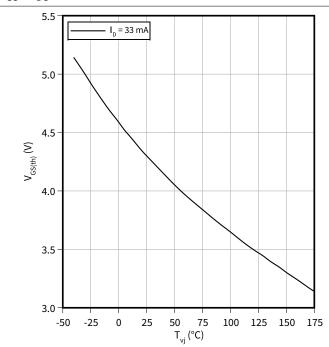
$$V_{DS} = 20 V$$



# Gate-source threshold voltage (typical), MOSFET, T1/

$$V_{GS(th)} = f(T_{vj})$$

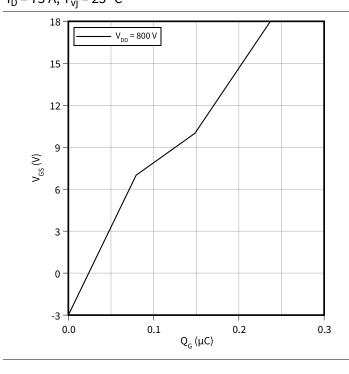
$$V_{GS} = V_{DS}$$



## Gate charge characteristic (typical), MOSFET, T1 / T2

$$V_{GS} = f(Q_G)$$

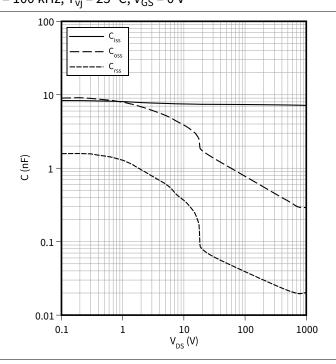
$$I_D = 75 A$$
,  $T_{vj} = 25 °C$ 



# Capacity characteristic (typical), MOSFET, T1 / T2

$$C = f(V_{DS})$$

$$f = 100 \text{ kHz}, T_{vj} = 25 \,^{\circ}\text{C}, V_{GS} = 0 \,^{\circ}\text{V}$$



11

#### EasyPACK™ module

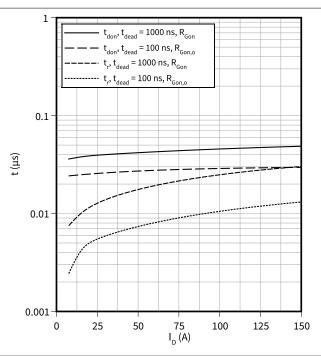




## Switching times (typical), MOSFET, T1 $\!\!/$ T2

 $t = f(I_D)$ 

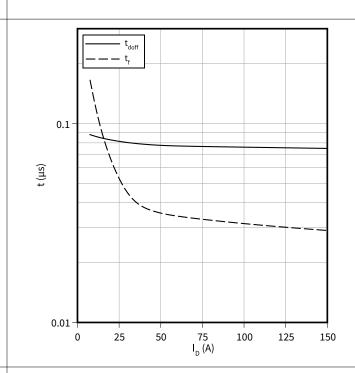
 $V_{DD}$  = 800 V,  $R_{Gon}$  = 10  $\Omega$ ,  $R_{Gon,o}$  = 1  $\Omega$ ,  $T_{vj}$  = 175 °C,  $V_{GS}$  = -3/18 V



# Switching times (typical), MOSFET, T1 $\!\!\!/$ T2

 $t = f(I_D)$ 

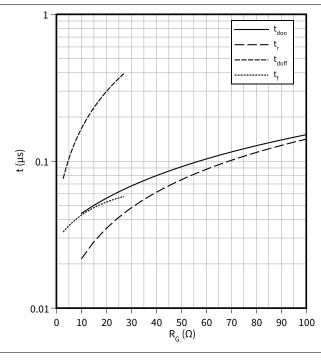
 $R_{Goff} = 2.7 \Omega$ ,  $V_{DD} = 800 V$ ,  $T_{vi} = 175 °C$ ,  $V_{GS} = -3/18 V$ 



# Switching times (typical), MOSFET, T1 / T2

 $t = f(R_G)$ 

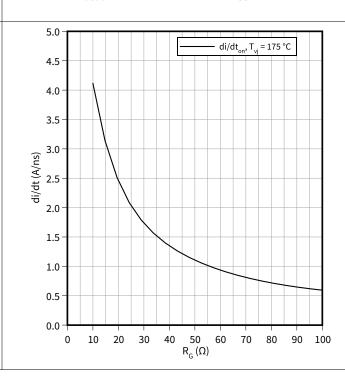
 $V_{DD}$  = 800 V,  $t_{dead}$  = 1000 ns,  $I_D$  = 75 A,  $T_{vj}$  = 175 °C,  $V_{GS}$  = -3/18 V



#### Current slope (typical), MOSFET, T1 / T2

 $di/dt = f(R_G)$ 

 $V_{DD}$  = 800 V,  $t_{dead}$  = 1000 ns,  $I_{D}$  = 75 A,  $V_{GS}$  = -3/18 V



#### EasyPACK™ module

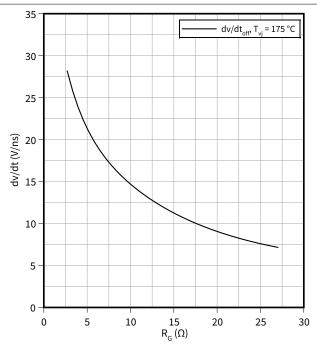
7 Characteristics diagrams



## Voltage slope (typical), MOSFET, T1 / T2

 $dv/dt = f(R_G)$ 

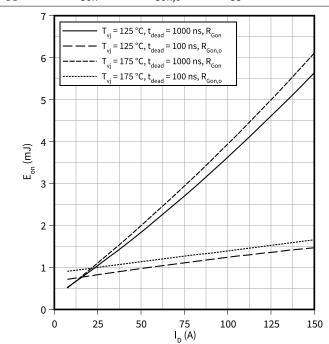
$$V_{DD}$$
 = 800 V,  $I_{D}$  = 75 A,  $V_{GS}$  = -3/18 V



#### Switching losses (typical), MOSFET, T1 / T2

 $E_{on} = f(I_D)$ 

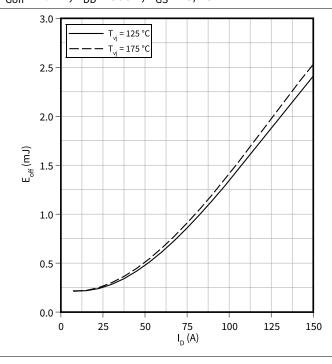
$$V_{DD}$$
 = 800 V,  $R_{Gon}$  = 10  $\Omega$ ,  $R_{Gon,o}$  = 1  $\Omega$ ,  $V_{GS}$  = -3/18 V



# Switching losses (typical), MOSFET, T1 / T2

 $E_{off} = f(I_D)$ 

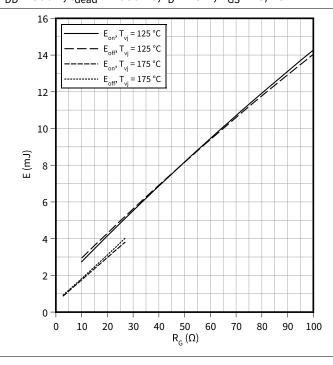
$$R_{Goff} = 2.7 \Omega$$
,  $V_{DD} = 800 V$ ,  $V_{GS} = -3/18 V$ 



#### Switching losses (typical), MOSFET, T1 / T2

 $E = f(R_G)$ 

$$V_{DD} = 800 \text{ V}, t_{dead} = 1000 \text{ ns}, I_D = 75 \text{ A}, V_{GS} = -3/18 \text{ V}$$



#### **EasyPACK™** module

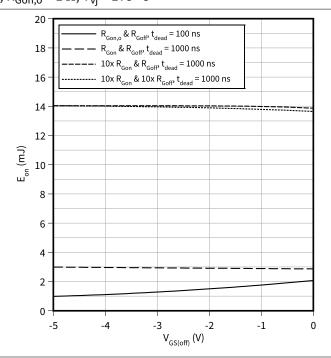
7 Characteristics diagrams



## Switching losses (typical), MOSFET, T1 / T2

 $E_{on} = f(V_{GS(off)})$ 

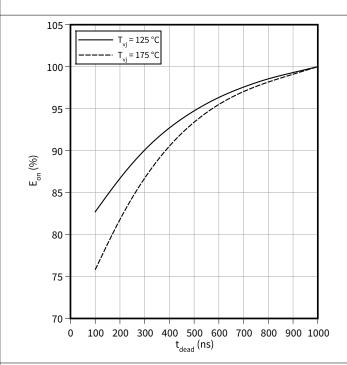
$$R_{Goff}$$
 = 2.7  $\Omega,$   $V_{DD}$  = 800 V,  $R_{Gon}$  = 10  $\Omega,$   $V_{GS(on)}$  = 18 V,  $I_D$  = 75 A,  $R_{Gon,o}$  = 1  $\Omega,$   $T_{vj}$  = 175 °C



#### Switching losses (typical), MOSFET, T1 / T2

 $E_{on} = f(t_{dead})$ 

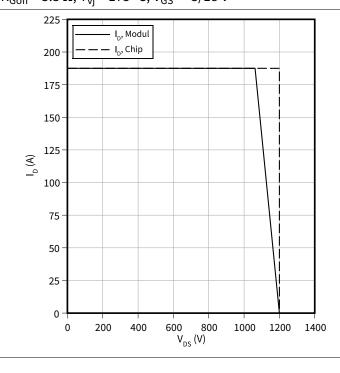
$$R_{Gon}$$
 = 10  $\Omega$ ,  $I_D$  = 75 A,  $V_{DD}$  = 800 V,  $V_{GS}$  = -3/18 V



#### Reverse bias safe operating area (RBSOA), MOSFET, T1 / T2

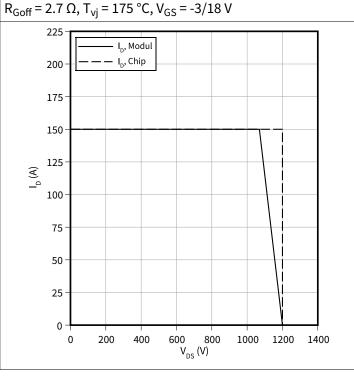
 $I_D = f(V_{DS})$ 

$$R_{Goff} = 3.3 \Omega, T_{vi} = 175 \,^{\circ}C, V_{GS} = -3/18 \,^{\circ}V$$



#### Reverse bias safe operating area (RBSOA), MOSFET, T1 / T2

 $I_D = f(V_{DS})$ 



#### EasyPACK™ module

7 Characteristics diagrams

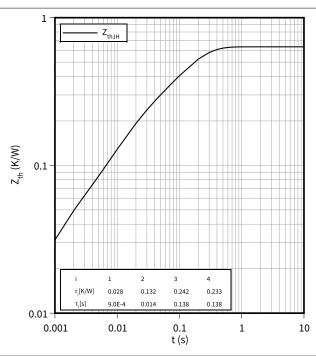


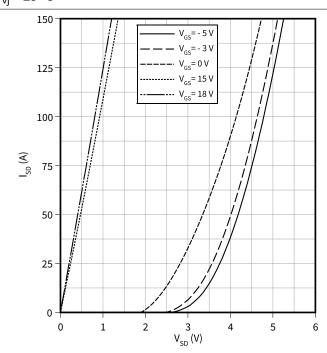
# Transient thermal impedance, MOSFET, T1 / T2

 $Z_{th} = f(t)$ 

# Forward characteristic body diode (typical), MOSFET, T1 / T2

$$I_{SD} = f(V_{SD})$$





# Switching losses body diode (typical), MOSFET, T1 / T2

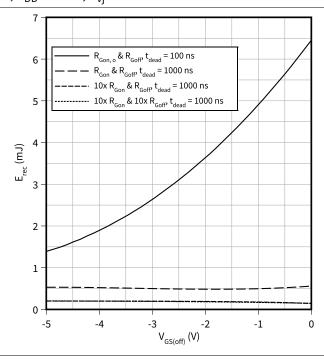
 $E_{rec} = f(V_{GS(off)})$ 

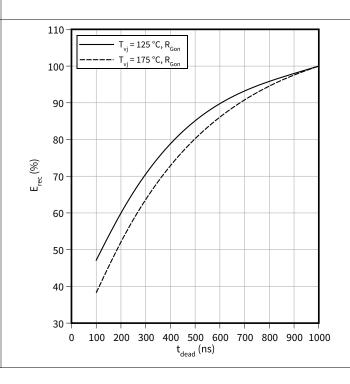
 $R_{Goff}$  = 2.7  $\Omega$ ,  $R_{Gon}$  = 10  $\Omega$ ,  $V_{GS(on)}$  = 18 V,  $I_{SD}$  = 75 A,  $R_{Gon,o}$  = 1  $\Omega$ ,  $V_{DD}$  = 800 V,  $T_{vj}$  = 175 °C

## Switching losses body diode (typical), MOSFET, T1 / T2

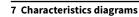
$$E_{rec} = f(t_{dead})$$

$$R_{Gon} = 10 \Omega$$
,  $I_D = 75 A$ ,  $V_{DD} = 800 V$ ,  $V_{GS} = -3/18 V$ 





#### EasyPACK™ module

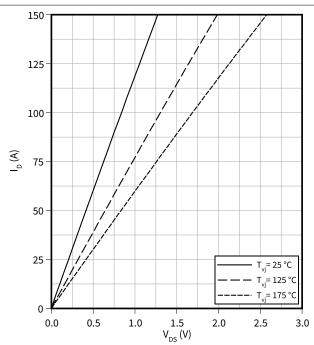




## Output characteristic (typical), MOSFET, T3 / T4

 $I_D = f(V_{DS})$ 

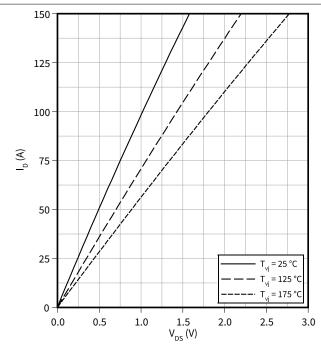
 $V_{GS} = 18 V$ 



## Output characteristic (typical), MOSFET, T3 / T4

 $I_D = f(V_{DS})$ 

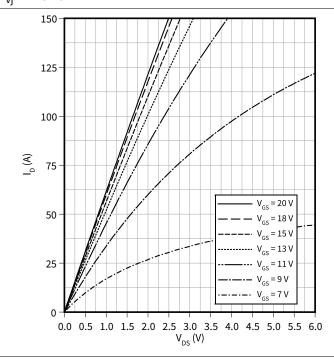
 $V_{GS} = 15 V$ 



## Output characteristic field (typical), MOSFET, T3 / T4

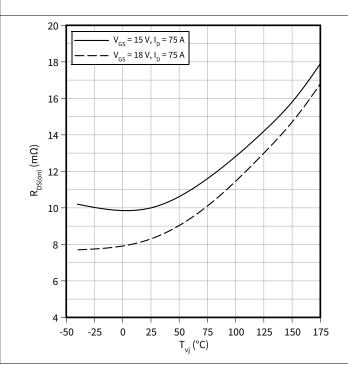
 $I_D = f(V_{DS})$ 

 $T_{vi} = 175 \,^{\circ}\text{C}$ 



# Drain source on-resistance (typical), MOSFET, T3 / T4

 $\mathsf{R}_{\mathsf{DS}(\mathsf{on})} = \mathsf{f}(\mathsf{T}_{\mathsf{v}\mathsf{j}})$ 



#### EasyPACK™ module

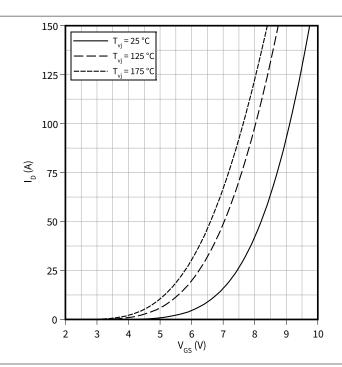
7 Characteristics diagrams



# Transfer characteristic (typical), MOSFET, T3 / T4

$$I_D = f(V_{GS})$$

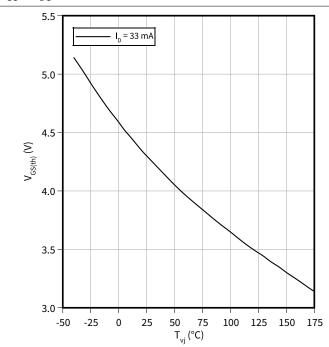
$$V_{DS} = 20 V$$



# Gate-source threshold voltage (typical), MOSFET, T3 /

$$V_{GS(th)} = f(T_{vj})$$

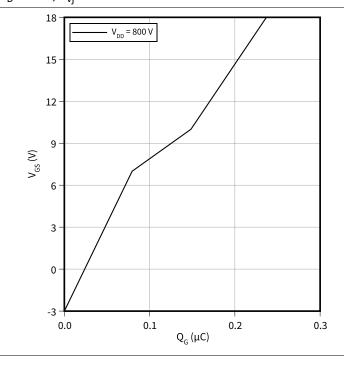
$$V_{GS} = V_{DS}$$



# Gate charge characteristic (typical), MOSFET, T3 / T4

$$V_{GS} = f(Q_G)$$

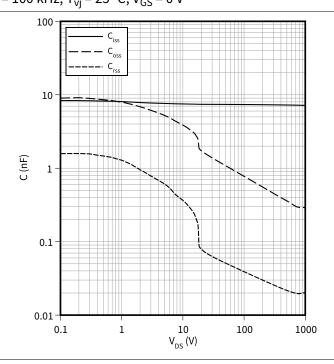
$$I_D = 75 A$$
,  $T_{vj} = 25 °C$ 



# Capacity characteristic (typical), MOSFET, T3 / T4

$$C = f(V_{DS})$$

$$f = 100 \text{ kHz}, T_{vj} = 25 \,^{\circ}\text{C}, V_{GS} = 0 \,^{\circ}\text{V}$$



#### **EasyPACK™** module

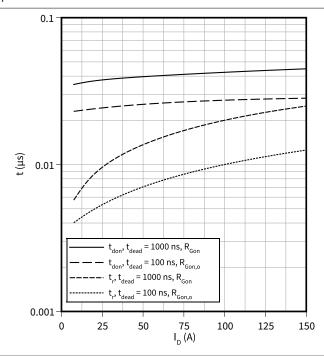




## Switching times (typical), MOSFET, T3 / T4

 $t = f(I_D)$ 

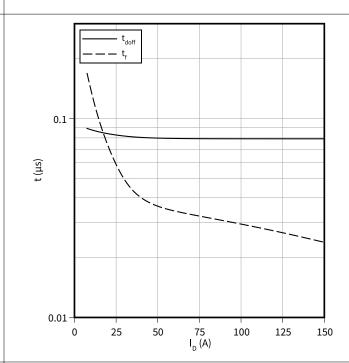
 $V_{DD}$  = 800 V,  $R_{Gon}$  = 5.6  $\Omega$ ,  $R_{Gon,o}$  = 0.0  $\Omega$ ,  $T_{vj}$  = 175 °C,  $V_{GS}$  = -3/18 V



## Switching times (typical), MOSFET, T3 / T4

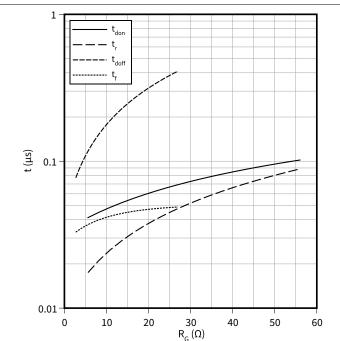
 $t = f(I_D)$ 

 $R_{Goff} = 2.7 \Omega$ ,  $V_{DD} = 800 V$ ,  $T_{vj} = 175 °C$ ,  $V_{GS} = -3/18 V$ 



# Switching times (typical), MOSFET, T3 / T4

 $V_{DD}$  = 800 V,  $t_{dead}$  = 1000 ns,  $I_{D}$  = 75 A,  $T_{vj}$  = 175 °C,  $V_{GS}$  = -3/18 V

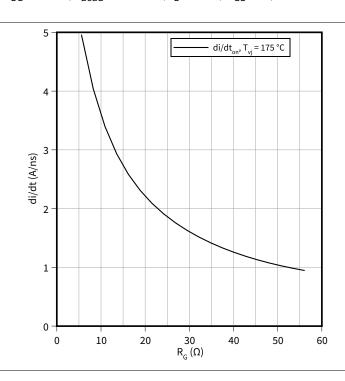


# Current slope (typical), MOSFET, T3 / T4

 $di/dt = f(R_G)$ 

18

 $V_{DD}$  = 800 V,  $t_{dead}$  = 1000 ns,  $I_{D}$  = 75 A,  $V_{GS}$  = -3/18 V



#### EasyPACK™ module

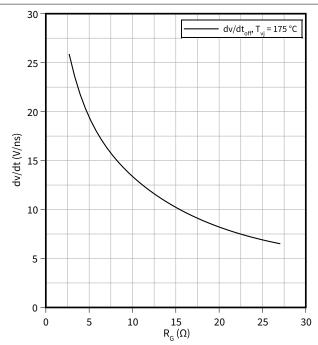
7 Characteristics diagrams



## Voltage slope (typical), MOSFET, T3 / T4

 $dv/dt = f(R_G)$ 

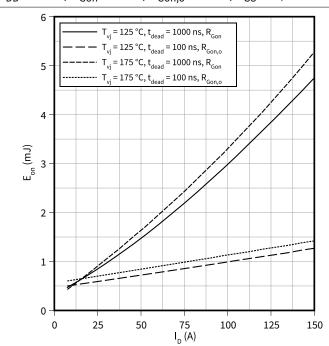
$$V_{DD}$$
 = 800 V,  $I_{D}$  = 75 A,  $V_{GS}$  = -3/18 V



#### Switching losses (typical), MOSFET, T3 / T4

 $E_{on} = f(I_D)$ 

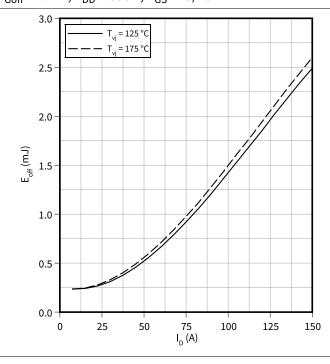
$$V_{DD}$$
 = 800 V,  $R_{Gon}$  = 5.6  $\Omega$ ,  $R_{Gon,o}$  = 0.0  $\Omega$ ,  $V_{GS}$  = -3/18 V



# Switching losses (typical), MOSFET, T3 / T4

 $E_{off} = f(I_D)$ 

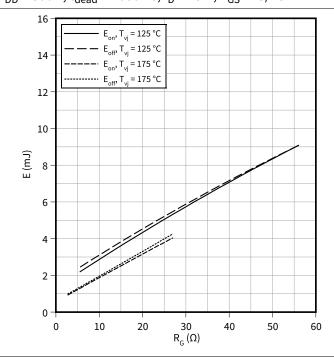
$$R_{Goff} = 2.7 \Omega$$
,  $V_{DD} = 800 V$ ,  $V_{GS} = -3/18 V$ 



#### Switching losses (typical), MOSFET, T3 / T4

 $E = f(R_G)$ 

$$V_{DD} = 800 \text{ V}, t_{dead} = 1000 \text{ ns}, I_{D} = 75 \text{ A}, V_{GS} = -3/18 \text{ V}$$



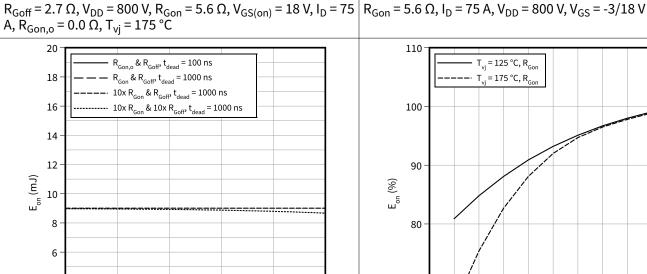
#### **EasyPACK™** module

7 Characteristics diagrams



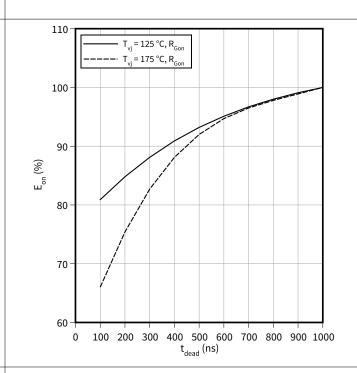
#### Switching losses (typical), MOSFET, T3 / T4

 $E_{on} = f(V_{GS(off)})$ 



#### Switching losses (typical), MOSFET, T3 / T4

 $E_{on} = f(t_{dead})$ 



#### Reverse bias safe operating area (RBSOA), MOSFET, T3 / T4

 $V_{GS(off)}(V)$ 

-1

 $I_D = f(V_{DS})$ 

4

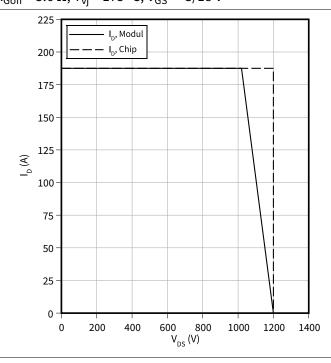
2

0

-5

 $R_{Goff} = 3.6 \Omega, T_{vi} = 175 \,^{\circ}C, V_{GS} = -3/18 \,^{\circ}V$ 

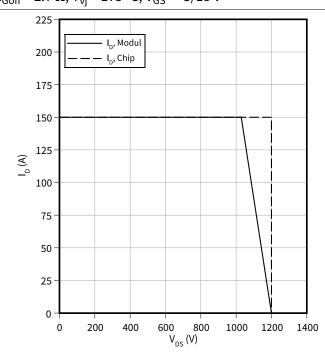
-4



#### Reverse bias safe operating area (RBSOA), MOSFET, T3 / T4

 $I_D = f(V_{DS})$ 

 $R_{Goff} = 2.7 \Omega$ ,  $T_{vi} = 175 \,^{\circ}$ C,  $V_{GS} = -3/18 \,^{\circ}$ V



#### EasyPACK™ module

7 Characteristics diagrams

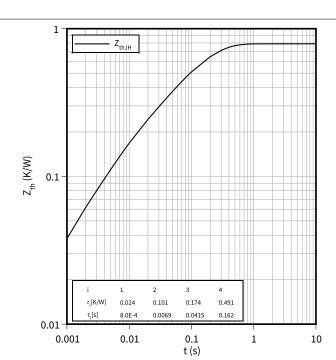


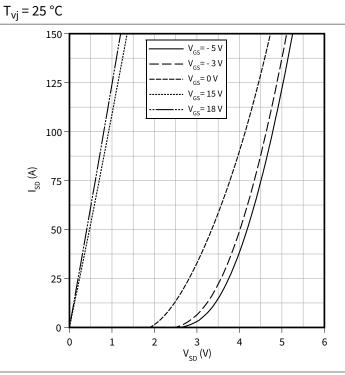
# Transient thermal impedance, MOSFET, T3 / T4

 $Z_{th} = f(t)$ 

# Forward characteristic body diode (typical), MOSFET, T3 / T4 $\,$

 $I_{SD} = f(V_{SD})$ 





## Switching losses body diode (typical), MOSFET, T3 / T4

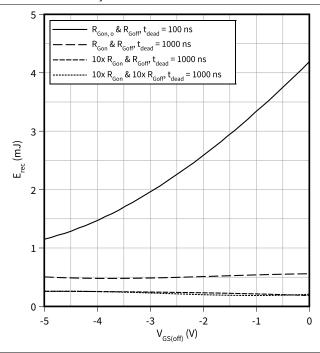
 $E_{rec} = f(V_{GS(off)})$ 

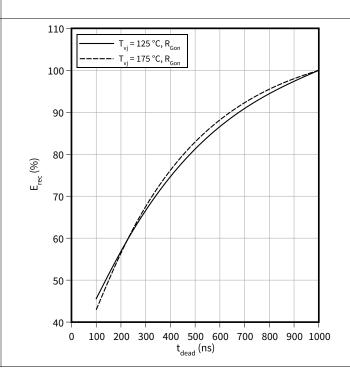
 $R_{Goff}$  = 2.7  $\Omega,$   $R_{Gon}$  = 5.6  $\Omega,$   $V_{GS(on)}$  = 18 V,  $I_{SD}$  = 75 A,  $R_{Gon,o}$  = 0  $\Omega,$   $V_{DD}$  = 800 V,  $T_{vj}$  = 175 °C



 $E_{rec} = f(t_{dead})$ 

 $R_{Gon} = 5.6 \Omega$ ,  $I_D = 75 A$ ,  $V_{DD} = 800 V$ ,  $V_{GS} = -3/18 V$ 

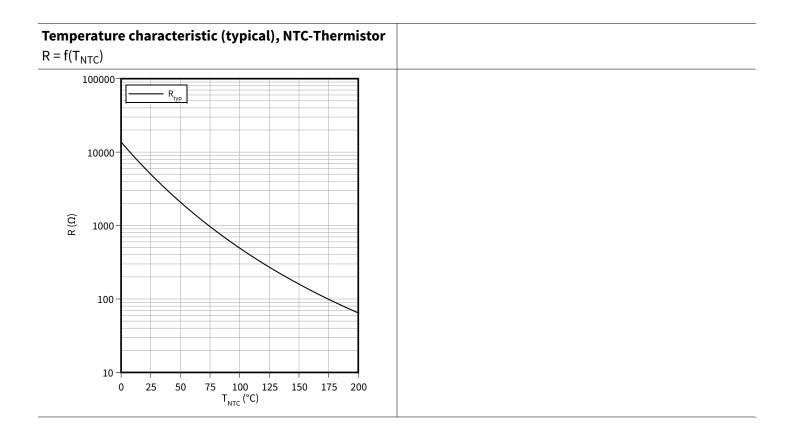




# **EasyPACK™ module**



7 Characteristics diagrams



8 Circuit diagram



# 8 Circuit diagram

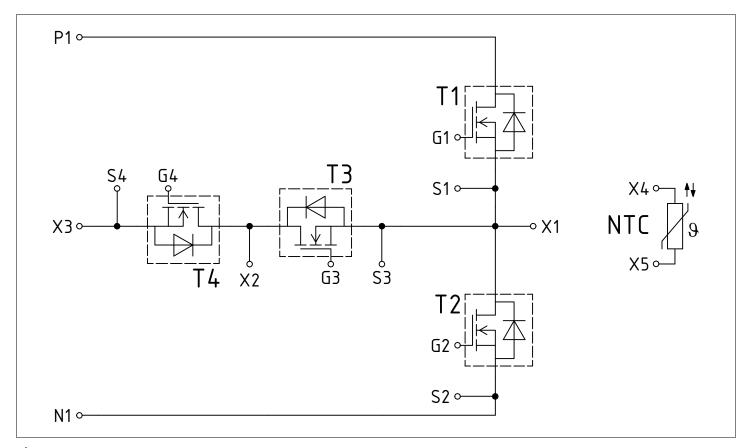


Figure 1

9 Package outlines



# 9 Package outlines

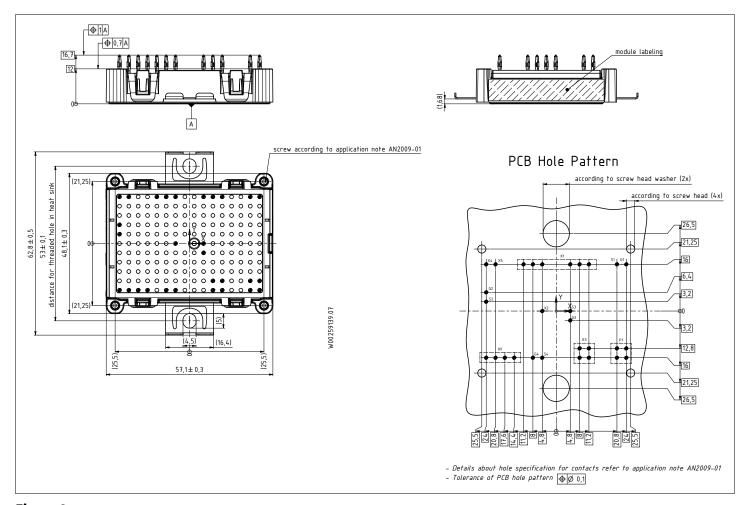


Figure 2

# **EasyPACK™ module**

10 Module label code



# 10 Module label code

Module label cod			1			
Code format	Data Matrix		Barcode C	Barcode Code128		
Encoding	ASCII text		Code Set A	A		
Symbol size	16x16		23 digits			
Standard	IEC24720 and IEC16022	IEC24720 and IEC16022				
Code content	Content	Digit		Example		
	Module serial number	1-5		71549		
	Module material number	6 - 11		142846		
	Production order number	12 - 19		55054991		
	Date code (production year)	20 – 21		15		
	Date code (production week)	30				
Example						

Figure 3

# **EasyPACK™ module**

Revision history



# **Revision history**

Document revision	Date of release	Description of changes
0.10	2025-01-29	Target datasheet
0.20	2025-06-17	Preliminary datasheet

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 ${\bf Email: erratum@infineon.com}$ 

Document reference IFX-ABM587-002

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